Docket No.: 67161-067 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Kiyoshi MAESHIMA

Serial No.: : Group Art Unit:

Filed: July 17, 2003 : Examiner:

For: PHOTO MASK, METHOD OF MANUFACTURING ELECTRONIC DEVICE, AND METHOD OF MANUFACTURING PHOTO MASK

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The relevance of three references listed on attached Form 1449 is discussed in the present specification.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

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Date: July 17, 2003

INFORMATION DISCLOSURE CITATION IN AN APPLICATION				ATTY. DOCKET NO. 67161-067	SERIAL NO.			
				APPLICANT Kiyoshi MAESHIMA				
(PTO-1449)				FILING DATE July 17, 2003	l '			
			U.S. PATE	NT DOCUMENTS				
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (# known)	Publication Dat MM-DD-YYYY		Name of Patentee or Applicant of Cited Document Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
		US						
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EXAMINER'S INITIALS	CITE NO.	Include name of the author (in journal, serial, symposium, cat published.	CAPITAL LETTER alog, etc.), date, p	RS), title of the article (when appropage(s), volume-issue number(s), p	priate), title of the it ublisher, city and/o	em (book, magazine, r country where		
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.